

**Search Notes**

Application/Control No.

10/564,028

Examiner

Tran N. Nguyen

Applicant(s)/Patent under  
Reexamination

GOTTMANN ET AL.

Art Unit

2834

**SEARCHED**

Class	Subclass	Date	Examiner
310	68R	4/24/07	/
	71		/
	51		/
	DIG-6		/
315	411		/
333	158		/
	181		/
336	221		/
	233		/
	175		/
	171	V	V

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner